Se	arcn	NOTE	es

Application/Control No.	Applicant(s)/Patent under Reexamination
10/537,704	LEWIS ET AL.
Examiner	Art Unit

1654

Hugh P. Young

SEARCHED				
Class	Subclass	Date	Examiner	
	-			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST(US-PGPUB; USPAT; USOCR; JPO;DERWENT)	2/14/2007	НРҮ		
STIC	12/29/2006	STIC		
STIC	2/5/2007	STIC		
STIC	1/26/2007	STIC		
STN (Registry, CAPLUS, Patents, BIOSIS, EMBASE, MEDLINE)	12/21/2006	HPY		